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	Application No.	Applicant(s)
Notice of Allowability	09/964,728	HOSOE, SHIGERU
	Examin r	Art Unit
	Jessica T Stultz	2873
The MAILING DATE of this communication app All claims being allowable, PROSECUTION ON THE MERITS IS herewith (or previously mailed), a Notice of Allowance (PTOL-85) NOTICE OF ALLOWABILITY IS NOT A GRANT OF PATENT R of the Office or upon petition by the applicant. See 37 CFR 1.313	(OR REMAINS) CLOSED in this applied or other appropriate communication IGHTS. This application is subject to 8 and MPEP 1308.	plication. If not included will be mailed in due course. THIS
2. The allowed claim(s) is/are 1,3-7,9-13, and 59-61.	WHO E 6, 2003.	
3. A The drawings filed on 28 September 2001 are accepted by	y the Examiner.	
Acknowledgment is made of a claim for foreign priority und a)	der 35 U.S.C. § 119(a)-(d) or (f).	
 Certified copies of the priority documents have 		
Certified copies of the priority documents have		
 Copies of the certified copies of the priority do International Bureau (PCT Rule 17.2(a)). 	cuments have been received in this	national stage application from the
* Certified copies not received:		
5. Acknowledgment is made of a claim for domestic priority under 35 U.S.C. § 119(e) (to a provisional application).		
(a) ☐ The translation of the foreign language provisional application has been received. 6. ☐ Acknowledgment is made of a claim for domestic priority under 35 U.S.C. §§ 120 and/or 121.		
Acknowledgment is made of a claim for domestic priority u	nder 35 U.S.C. 99 120 and/or 121.	
Applicant has THREE MONTHS FROM THE "MAILING DATE" of below. Failure to timely comply will result in ABANDONMENT of		
7. A SUBSTITUTE OATH OR DECLARATION must be submINFORMAL PATENT APPLICATION (PTO-152) which gives reas		
CORRECTED DRAWINGS must be submitted. (a) ☐ including changes required by the Notice of Draftsper 1) ☐ hereto or 2) ☐ to Paper No (b) ☐ including changes required by the proposed drawing or including changes required by the attached Examiner.	correction filed, which has b	een approved by the Examiner.
Identifying Indicia such as the application number (see 37 CFR 1 each sheet.	.84(c)) should be written on the drawin	ngs in the front (not the back) of
DEPOSIT OF and/or INFORMATION about the depo attached Examiner's comment regarding REQUIREMENT FOR T		
Attachm nt(s)		
Notice of References Cited (PTO-892)	4☐ Interview Summ 6☐ Examiner's Ame	al Patent Application (PTO-152) ary (PTO-413), Paper No ndment/Comment ament of Reasons for Allowance
	gy.	MP 10/8/05

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Allowed Claims: 1, 3-7, 9-13, and 59-61

Reasons for Allowance

The following is an examiner's statement of reasons for allowance: none of the prior art alone or in combination disclose or teach of the claimed combination of limitations to warrant a rejection under 35 USC 102 or 103.

Specifically regarding independent claims 1 and 7, none of the prior art alone or in combination disclose or teach of the claimed optical element specifically wherein the predetermined optical function is represented by the claimed formula.

Conclusion

Any comments considered necessary by applicant must be submitted no later than the payment of the issue fee and, to avoid processing delays, should preferably accompany the issue fee. Such submissions should be clearly labeled "Comments on Statement of Reasons for Allowance"

Any inquiry concerning this communication or earlier communications from the examiner should be directed to Jessica T Stultz whose telephone number is (703) 305-6106. The examiner can normally be reached on M-F 8-4:30.

If attempts to reach the examiner by telephone are unsuccessful, the examiner's supervisor, Georgia Epps can be reached on 703-308-4883. The fax phone number for the organization where this application or proceeding is assigned is (703) 872-9306.

Any inquiry of a general nature or relating to the status of this application or proceeding should be directed to the receptionist whose telephone number is 703-308-0956.

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Jessica Stultz

JORDAN SCHWARTZ PRIMARY EXAMINER